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U.S. DEPARTMENT OF
COMMERCE
PATENT AND TRADEMARK
OFFICEATTY. DOCKET NO.
45532/1:7APPLICATION NO.
10/053,483

-80)

JUN 05 2002

APPLICANT

Ronald A. Palfenier et al.

INFORMATION DISCLOSURE CITATION

(Use several sheets if necessary)

FILING DATE
November 2, 2001

GROUP

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
WF	AA	6	0	0	7	2	4	1	Dec 1999	Yam et al.	374	131	
WF	AB	5	8	9	7	6	1	0	Apr 1999	Jensen	702	134	
WF	AC	5	8	1	5	4	1	0	Sep 1998	Heinke et al.	364	557	
WF	AD	5	7	1	7	6	0	8	Feb 1998	Jensen	364	557	
WF	AE	5	7	0	4	7	1	2	Jan 1998	Stein	374	126	
WF	AF	5	6	9	0	4	2	9	Nov 1997	Ng	374		
WF	AG	5	1	5	4	5	1	2	Oct 1992	Scheitinger et al.	374	9	
WF	AH	4	9	5	6	5	3	8	Sep 1990	Moslehi	219	121.6	
WF	AI	4	8	4	5	6	4	7	Jul 1989	Dils et al.	364	557	
WF	AJ	4	7	5	0	1	3	9	Jun 1988	Dils	364	557	
WF	AK	4	5	7	4	4	8	6	Mar 1986	Dils	374	131	

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS.	SUBCLASS	TRANSLATION	
							YES	NO
	AL							
	AM							
	AN							
	AO							
	AP							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

WF	AR	"Optical Pyrometry Begins to Fulfill its Promise," Alexander Braun, Semiconductor International, March 1998, pp. 1 and 2.
WF	AS	"A New Detector for IRLED Light," Russ Dahl and Michael Allen, reprinted from SENSORS Magazine, December 1996, 4 pp.
	AT	

EXAMINER

Demetrio P. Tito

DATE CONSIDERED

12/10/03

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation

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DP	AA	4	3	4	8 1 1 0	Sep 1982	Ito	356 328
DP	AB	4	0	7	5 4 9 3	Feb 1978	Wickersheim	250 461 R
DP	AC	3	6	2	6 7 5 8	Dec 1971	Stewart et al.	73 355R
DP	AD	2	7	0	9 3 6 7	May 1955	Bohnet	73 355
DP	AE	1	6	3	9 5 3 4	Aug 1927	Ruben	
DP	AF	1	4	7	5 3 6 5	Nov 1923	Schueler et al.	
	AG							
	AH							
	AI							
	AJ							
	AK							

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